

Pulser test

With this test we want to understand how the gain changes during the calibrations and if this is a trustable process. First we need to determine the gain

Gain Determination of our Pre-Amp

In the lab

1. Connect LVDS cable of our pre-amp to the first FEBEX card
 2. Connect, with a LEMO the pulser, to the pulser input of our pre-amp
 3. Connect BUS 0 in the MRC-1 (master connector) to our entry in the pre-amp
 4. Change modes in the Pulser to Local mode (Go to Main Menu → Option 6)
-

In the PC

1. Connect to FEBEX PC
2. pb5 get 1 all (this shows what are the parameters that we can change)
3. go2Febex
4. ssh lipc-4
5. /mbsrun/febex/lipc-4
6. resa
7. make clean
8. make
9. mbs
10. @startup
11. connect rfio 192.168.2.12:1290 -diskserver
12. sho acq (this must show some events)
13. open file name=/d/d01-1/agkr/CALIFA/CALIFA_Ring9/Tomas_DATA/cosmic_test/lmdFiles/220613_run -rfio size=1000 -auto first=1
14. close file

Check events

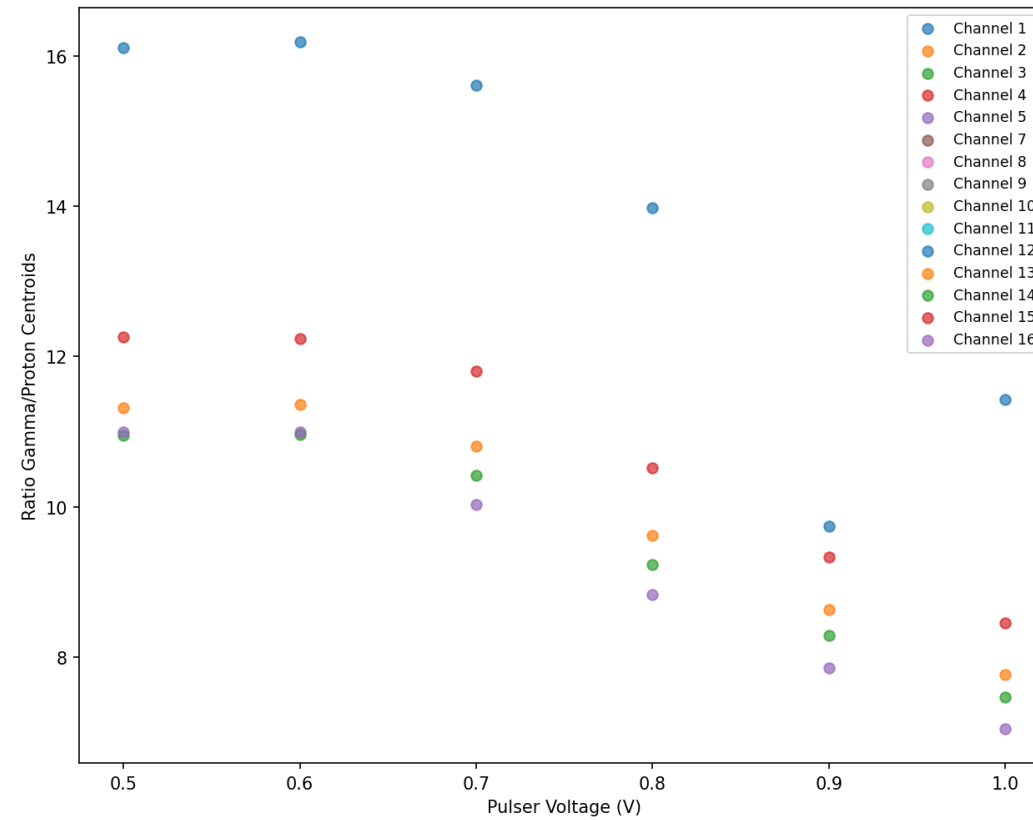
1. tomas
2. cd cosmic_test/
3. . unpack.sh 220705

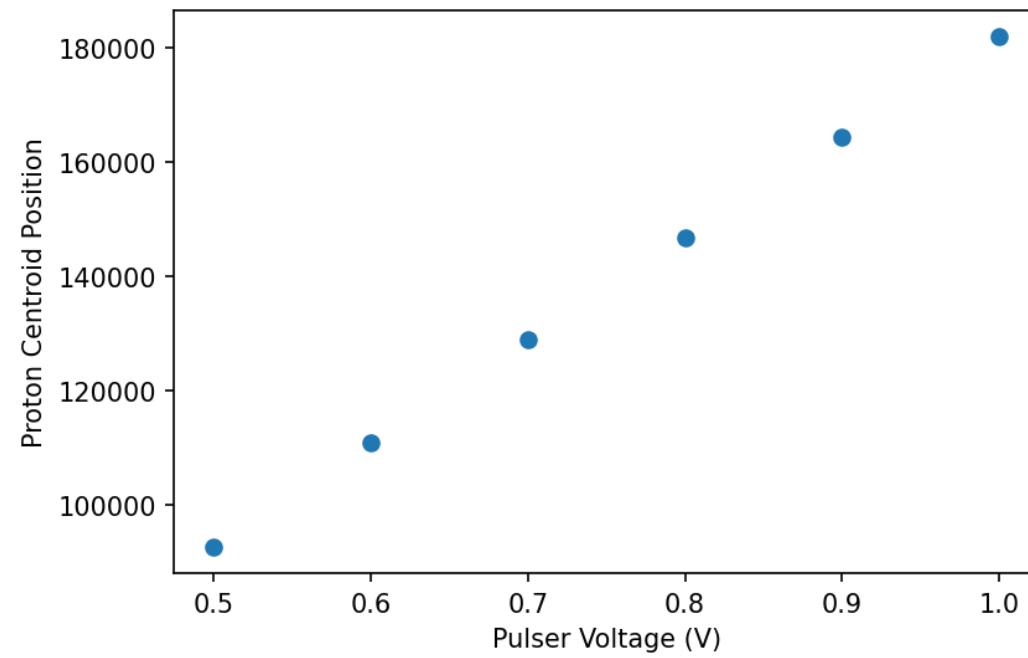
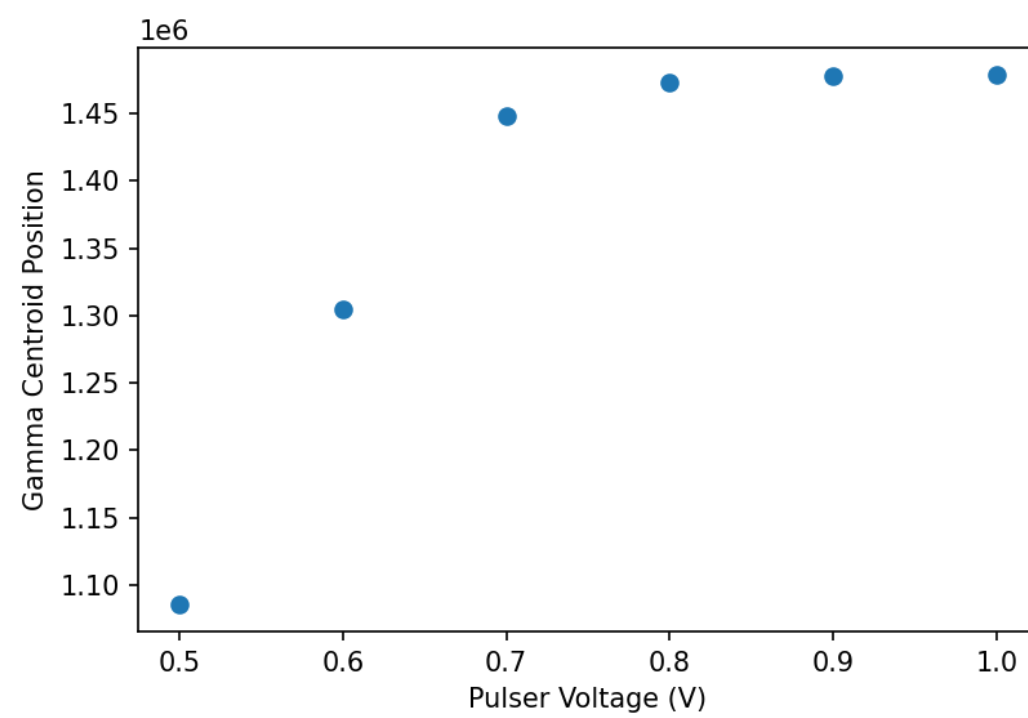
4. AnalysisxTree→StartViewer() (to check the structure of events)

5. AnalysisxTree→Draw("I_Csl[0]")

Other ways of Drawing: <https://root.cern.ch/root/html/doc/guides/users-guide/Trees.html#simple-analysis-using-ttreedraw>

Results of 1st test





This results shows that for the gamma centroids, after the 0.7 voltage we have saturation. This is already expected, since that for a certain voltage this would go out the gamma range.

Nevertheless, in the first graph we see that even for the 0.5 and 0.6 values, the ratio for different channels, changes a lot, it would induce 9% errors in the calibration.

Also, some of the proton channels have 0 counts and I don't know why...

There is also the need to re-do the test with the rise time and decay time similar to the CsI(Tl) response of the crystals.

Reference: <https://arxiv.org/pdf/1103.6105.pdf>

Table. 2 Summary of waveform parameters.

Crystals	CsI(Na)		CsI(Tl)		NaI(Tl)		CsI	
Source	γ	α	γ	α	γ	α	γ	α
Rise time (ns)	40	5	50	35	20	10	5	5
Decay time (ns)	670	17 _{fast}	1080	670	250	170	22	15
		490 _{slow}						

New test

- Pulse from 0.1 to 1 V, in intervals of 0.1V
- Change the rise time and decay time to the same as CsI(Tl) in the pulser